Docket No. 249705US2SDIV

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

GAU:

IN RE APPLICATION OF: Hideo ANDO, et al.

SERIAL NO: New DIV Application

Herewith EXAMINER:

FOR: INFORMATION STORAGE SYSTEM CAPABLE OF RECORDING AND PLAYING BACK A PLURALITY OF

STILL PICTURES

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR

FILED:

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Applicant(s) wish to disclose the following information.

REFERENCES

The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed
references were provided in previous U.S. Application Nos. 09/348,267, filed July 7, 1999, 09/630,430, filed
August 1, 2000, and 10/076,284, filed February 19, 2002.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present
application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s)
is attached along with PTO 1449.

A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

Each item of information contained in this information disclosure statement was first cited in any communication
from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of
this statement.

□ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

James J. Kulbaski

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Customer Number

22850

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Scott A. McKeown

Registration No. 42,866

Form PTO 1449		U.S. DEPARTMENT O	F COMMERCE	ATTY DOCKET NO.	•	SERIAL!	NO.
(Modified) PATENT AND TRADEMARK OFFICE			249705US2SDIV	New DIV Application			
				APPLICANT			
LIST OF	REFE	RENCES CITED BY APP	PLICANT	Hideo ANDO, et al.			
		·		FILING DATE		GROUP	
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			ι	J.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,712,947	01/27/1998	Oguro, et al.			
	AB	6,385,389	05/07/02	Maruyama, et al.			
	AC	6,148,138	11/14/2000	Sawabe, et al.			
	AD	6,421,499	07/2002	Kim, et al.			
	AE	6,253,026	06/2001	Saeki, et al.			
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		DOCUMENT NUMBER	DATE	COUNTRY		YES	TRANSLATION NO
	AG	EP 1 065 665 A1	01/03/2001	European Patent Office (in English)			
	АН	JP 5-165935	07/02/1993	JAPAN		Х	
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1	AJ	JP 7-143429	06/02/1995	JAPAN		×	
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	AL	JP 9-259539	10/03/1997	JAPAN		×	
	AM	JP 11-215471	08/06/1999	JAPAN (corresponding U.S. Patent no. 6,385,389 B1 Maruyama, et al.)			×
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	AR	JP 9-182013	07/11/1997	JAPAN		×	
		JP 11-136613	05/21/1999	JAPAN		X	
		OTHER REI	ERENCES (I	ncluding Author, Title, Date, Pertinent	Pages, et	c.)	
	AS Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310033 (with English translation)						No. 2001-310033 (with
	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310034 (with AT English translation)						No. 2001-310034 (with
	AU	Explanation of Circumsta English translation)	ances concern	ing Accelerated Examination for Japane	se Patent /	Application	No. 2001-310035 (with
	AV	Explanation of Circumsta English translation)	ances concern	ing Accelerated Examination for Japanes	se Patent /	Application	No. 2001-310036 (with
	AW		ances concern	ing Accelerated Examination for Japanes	se Patent /	Application	No. 2001-310037 (with
,	АХ				Addi	ional Refe	rences sheet(s) attached
Examiner	Examiner Date Considered						
*Examiner: Ini	tial if re	eference is considered, w t considered, Include con	hether or not o	citation is in conformance with MPEP 609 with next communication to applicant.	; Draw line	through c	itation if not in
			,	aniodion to applicant.			

Form PTO 1449		U.S. DEPARTMENT OF COMMERCE		ATTY DOCKET NO.		SERIAL NO.				
(Modified)		PATENT AND TRAC	DEMARK OFFICE	249705US2SDIV	New DIV Application					
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				FILING DATE		GROUP				
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				U.S. PATENT DOCUMENTS						
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	AB	5,687,160	11/1997	Aotake, et al.						
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	AE	6,067,400	05/2000	Saeki, et al.						
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		OTHER RE	FERENCES (Including Author, Title, Date, Perti	nent Pages, e	tc.)				
···	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2002-87033 (w/English translation)							002-87033		
	AX	Explanation of Circums (w/English translation)		rning Accelerated Examination for Ja	panese Paten	t Applicatio	n No. 1	998-192063		
	AY	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 1999-256210 (w/English translation)								
	AZ									
Examiner						Additional References sheet(s) attach				
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